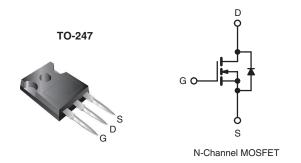


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.27		
Q _g (Max.) (nC)	120			
Q _{gs} (nC)	32			
Q _{gd} (nC)	49			
Configuration	Single			



FEATURES

- · Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Reduced C_{iss}, C_{oss}, C_{rss}
- Isolated Central Mounting Hole
- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Lead (Pb)-free Available



DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFETs technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole.

ORDERING INFORMATION		
Package	TO-247	
Lead (Pb)-free	IRFP460LCPbF	
	SiHFP460LC-E3	
SnPb	IRFP460LC	
	SiHFP460LC	

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	500	V	
Gate-Source Voltage	V_{GS}	± 30	\ \ \		
Continuous Drain Current	V_{GS} at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I-	20	А	
	$T_C = 100 ^{\circ}$ C	I _D	12		
Pulsed Drain Current ^a	I _{DM}	80			
Linear Derating Factor			2.2	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	960	mJ		
Repetitive Avalanche Current ^a	I _{AR}	20	Α		
Repetitive Avalanche Energy ^a	E _{AR}	28	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	280	W	
Peak Diode Recovery dV/dtc	dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	7	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF M3 SCIEW		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 4.3 mH, R_G = 25 Ω , I_{AS} = 20 A (see fig. 12). c. I_{SD} \leq 20 A, dI/dt \leq 160 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C.
- d. 1.6 mm from case.
- * Pb containing terminations are not RoHS compliant, exemptions may apply

IRFP460LC, SiHFP460LC

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	=	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.45	

SPECIFICATIONS $T_J = 25 ^{\circ}C$,	unless other	wise noted					
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I _D = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	٧
Gate-Source Leakage	I _{GSS}	V _G	V _{GS} = ± 20 V		-	± 100	nA
Zone Ooto Walkers Busin Oursel		V _{DS} = 500 V, V _{GS} = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V, V	/ _{GS} = 0 V, T _J = 125 °C	-	-	250	- μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 12 A ^b	-	-	0.27	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 5	60 V, I _D = 12 A ^b	12	-	-	S
Dynamic				I.	ı	•	
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	3600	-	pF
Output Capacitance	C _{oss}			-	440	-	
Reverse Transfer Capacitance	C _{rss}			-	39	-	
Total Gate Charge	Qg		I _D = 20 A, V _{DS} = 400 V, see fig. 6 and 13 ^b	-	-	120	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V		-	-	32	
Gate-Drain Charge	Q _{gd}	1		-	-	49	
Turn-On Delay Time	t _{d(on)}			-	18	-	
Rise Time	t _r	$V_{DD} = 2$	V _{DD} = 250 V, I _D = 20 A		77	-	ns
Turn-Off Delay Time	t _{d(off)}	$R_G = 4.3 \Omega$, $R_D = 12 \Omega$, see fig. 10^b		-	40	-	
Fall Time	t _f			-	43	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L _S			-	13	-	- nH
Drain-Source Body Diode Characteristic	s			I.			
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	80	A
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 20 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 20 A, dl/dt = 100 A/μs ^b		-	570	860	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	6.6	9.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

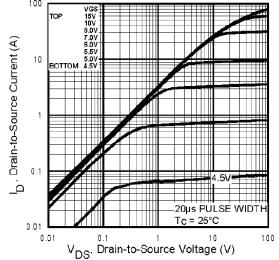


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

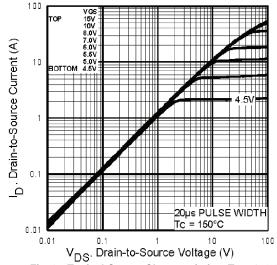


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

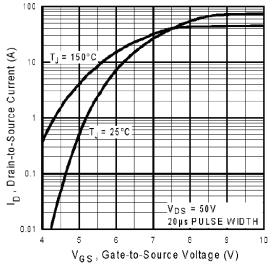


Fig. 3 - Typical Transfer Characteristics

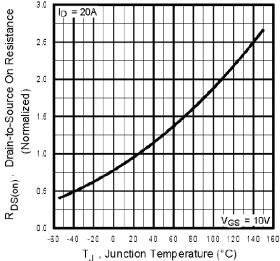


Fig. 4 - Normalized On-Resistance vs. Temperature

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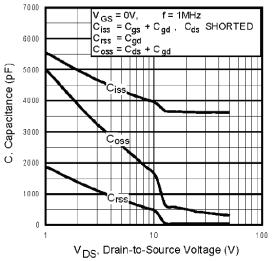


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

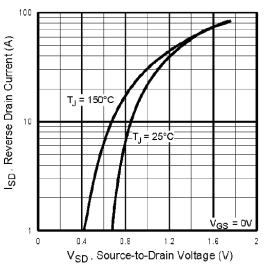


Fig. 7 - Typical Source-Drain Diode Forward Voltage

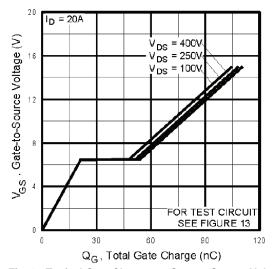


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

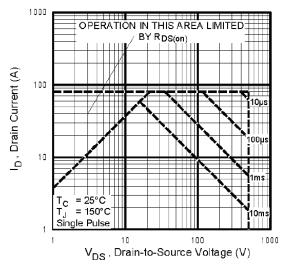


Fig. 8 - Maximum Safe Operating Area



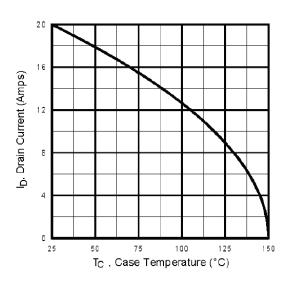


Fig. 9 - Maximum Drain Current vs. Case Temperature

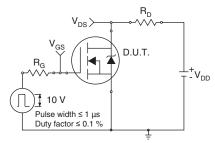


Fig. 10a - Switching Time Test Circuit

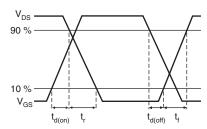


Fig. 10b - Switching Time Waveforms

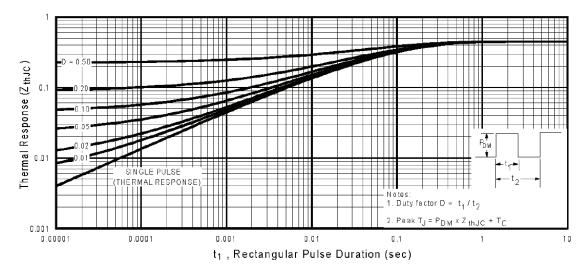


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

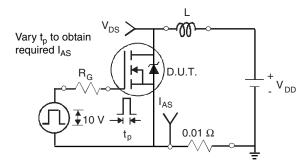


Fig. 12a - Unclamped Inductive Test Circuit

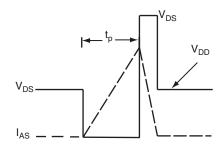


Fig. 12b - Unclamped Inductive Waveforms

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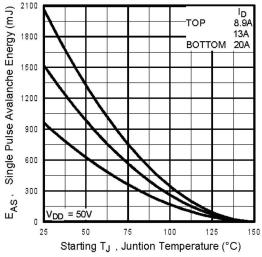


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

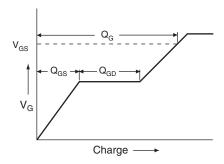


Fig. 13a - Basic Gate Charge Waveform

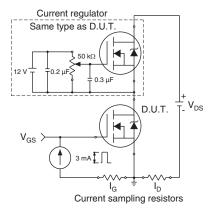
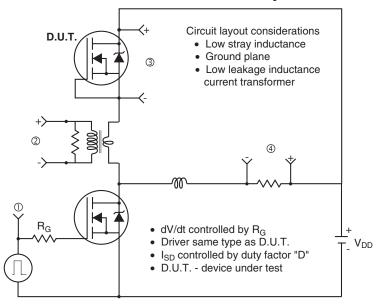
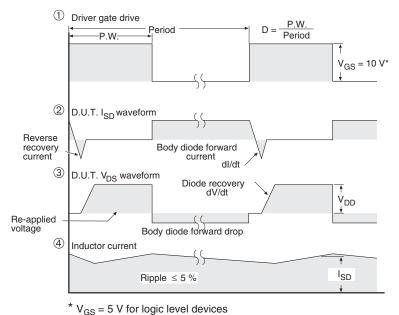


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





logio level devides

Fig. 14 - For N-Channel

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com